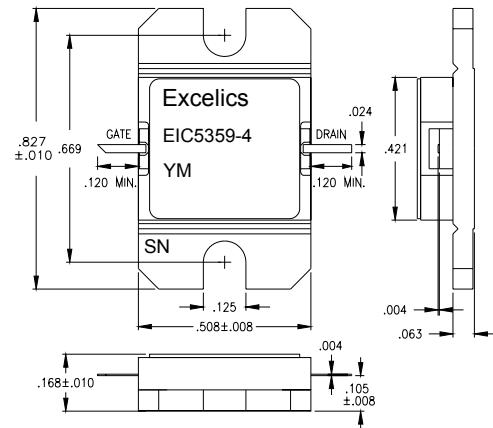


ISSUED 5/15/2006

5.3-5.9 GHz 4-Watt Internally Matched Power FET

FEATURES

- 5.3– 5.9GHz Bandwidth
- Input/Output Impedance Matched to 50 Ohms
- +36.5 dBm Output Power at 1dB Compression
- 10.5 dB Power Gain at 1dB Compression
- 34% Power Added Efficiency
- Hermetic Metal Flange Package



ELECTRICAL CHARACTERISTICS (T_a = 25°C)



Caution! ESD sensitive device.

SYMBOL	PARAMETERS/TEST CONDITIONS ¹	MIN	TYP	MAX	UNITS
P_{1dB}	Output Power at 1dB Compression V _{DS} = 10 V, I _{DSQ} ≈ 1100mA f = 5.3-5.9GHz	35.5	36.5		dBm
G_{1dB}	Gain at 1dB Compression V _{DS} = 10 V, I _{DSQ} ≈ 1100mA f = 5.3-5.9GHz	9.5	10.5		dB
ΔG	Gain Flatness V _{DS} = 10 V, I _{DSQ} ≈ 1100mA f = 5.3-5.9GHz			±0.6	dB
PAE	Power Added Efficiency at 1dB Compression V _{DS} = 10 V, I _{DSQ} ≈ 1100mA f = 5.3-5.9GHz		34		%
I_{d1dB}	Drain Current at 1dB Compression f = 5.3-5.9GHz		1200	1400	mA
IM3	Output 3rd Order Intermodulation Distortion Δf=10MHz 2-Tone Test. P _{out} =25.5 dBm S.C.L V _{ds} = 10 V, I _{DSQ} ≈ 65% I _{DSS} f = 5.9GHz	-43	-46		dBc
I_{DSS}	Saturated Drain Current V _{DS} = 3 V, V _{GS} = 0 V		2000	2500	mA
V_P	Pinch-off Voltage V _{DS} = 3 V, I _{DS} = 20 mA		-2.5	-4.0	V
R_{TH}	Thermal Resistance ³		5.5	6	°C/W

Note: 1) Tested with 100 Ohm gate resistor. 2) S.C.L. = Single Carrier Level. 3) Overall R_{th} depends on case mounting.

ABSOLUTE MAXIMUM RATING^{1,2}

SYMBOLS	PARAMETERS	ABSOLUTE ¹	CONTINUOUS ²
V_{ds}	Drain-Source Voltage	15	10V
V_{gs}	Gate-Source Voltage	-5	-4V
I_{gsf}	Forward Gate Current	43.2mA	14.4mA
I_{gsr}	Reserve Gate Current	-7.2mA	-2.4mA
P_{in}	Input Power	35.5dBm	@ 3dB Compression
T_{ch}	Channel Temperature	175 °C	175 °C
T_{stg}	Storage Temperature	-65 to +175 °C	-65 to +175 °C
P_t	Total Power Dissipation	25W	25W

Note: 1. Exceeding any of the above ratings may result in permanent damage.
 2. Exceeding any of the above ratings may reduce MTTF below design goals.